## Notice of References Cited Application/Control No. 10/617,079 Examiner HIEP NGUYEN Applicant(s)/Patent Under Reexamination FABRICK ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,684,276	01-2004	Walker et al.	710/73
*	В	US-2002/0145634	10-2002	Gueramy et al.	345/840
*	С	US-5,772,585	06-1998	Lavin et al.	600/300
*	D	US-6,804,656	10-2004	Rosenfeld et al.	705/3
*	Е	US-2002/0188896	12-2002	Filteau et al.	714/57
*	F	US-5,737,539	04-1998	Edelson et al.	705/3
	G	US-			
	Ι	US-			
	-	US-			
	7	US-			
	K	US-			
	┙	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	C						
	>						
	w						
	х						

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.